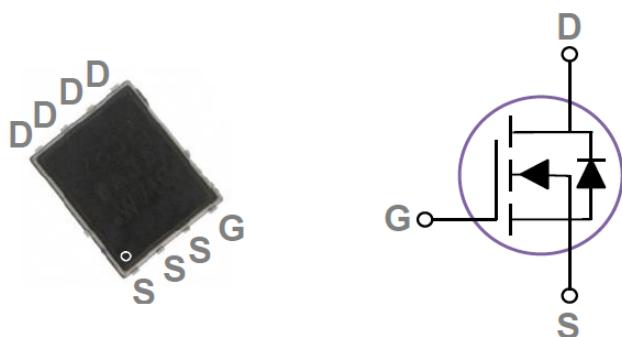


## General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

## DFN5X6 Pin Configuration



BVDSS	RDS(ON)	ID
65V	5.6mΩ	83A

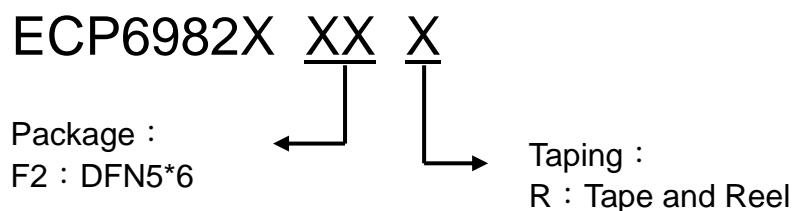
## Features

- ◆ 65V, 83A, RDS(ON) = 5.6mΩ @VGS = 10V
- ◆ Improved dv/dt capability
- ◆ Fast switching
- ◆ 100% EAS Guaranteed
- ◆ Green Device Available

## Application

- ◆ Networking
- ◆ Load Switch
- ◆ LED applications
- ◆ Quick Charger

## Ordering / Marking Information



Part Number	Marking	Marking Information
ECP6982XF2R	6982X LLLLL YYWW	LLLLL : Lot No YYWW : Date Code

**Absolute Maximum Ratings** T<sub>c</sub>=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	65	V
V <sub>GS</sub>	Gate-Source Voltage	±20/-12	V
I <sub>D</sub>	Drain Current – Continuous (T <sub>c</sub> =25°C)	83	A
	Drain Current – Continuous (T <sub>c</sub> =100°C)	52	A
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	332	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	140	mJ
IAS	Single Pulse Avalanche Current <sup>2</sup>	53	A
P <sub>D</sub>	Power Dissipation (T <sub>c</sub> =25°C)	96	W
	Power Dissipation – Derate above 25°C	0.77	W/°C
T <sub>STG</sub>	Storage Temperature Range	-50 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-50 to 150	°C

**Thermal Characteristics**

Symbol	Parameter	Typ.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction to ambient	---	62	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction to Case	---	1.3	°C/W

**Electrical Characteristics** T<sub>j</sub>=25 °C , unless otherwise noted**Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	65	---	---	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA	---	0.03	---	°C/W
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =60V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C	---	---	1	uA
		V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =85°C	---	---	10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =20V , V <sub>DS</sub> =0V	---	---	100	nA

**On Characteristics**

R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =20A	---	4.6	5.6	mΩ
		V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A	---	8.2	10.5	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1	1.6	2.5	V
	ΔV <sub>GS(th)</sub>		---	-5.5	---	mV/°C
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =3A	---	10	---	S

**Dynamic and switching Characteristics**

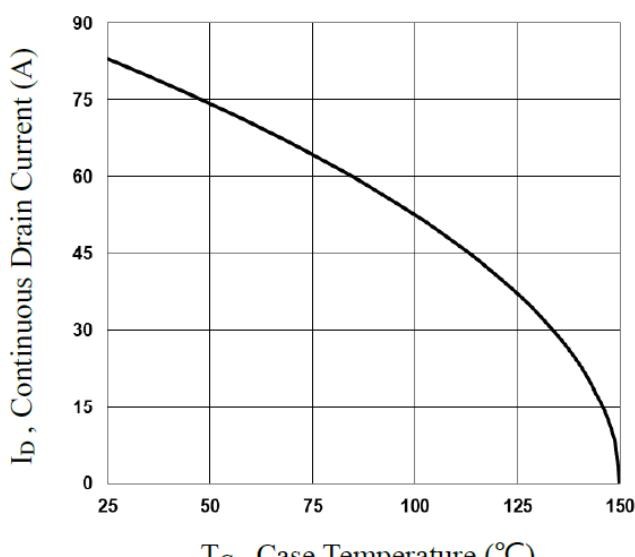
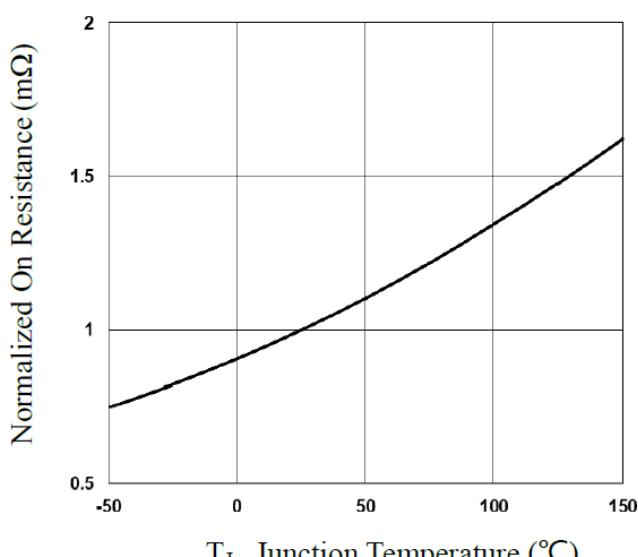
$Q_g$	Total Gate Charge <sup>3, 4</sup>	$V_{DS}=30V, V_{GS}=10V, I_D=15A$	---	34.7	70	nC
$Q_{gs}$	Gate-Source Charge <sup>3, 4</sup>		---	4.9	10	
$Q_{gd}$	Gate-Drain Charge <sup>3, 4</sup>		---	11.1	22	
$T_{d(on)}$	Turn-On Delay Time <sup>3, 4</sup>	$V_{DD}=30V, V_{GS}=10V, R_G=6\Omega, I_D=1A$	---	10.2	21	ns
$T_r$	Rise Time <sup>3, 4</sup>		---	16	32	
$T_{d(off)}$	Turn-Off Delay Time <sup>3, 4</sup>		---	42	84	
$T_f$	Fall Time <sup>3, 4</sup>		---	38	76	
$C_{iss}$	Input Capacitance		---	1910	3800	pF
$C_{oss}$	Output Capacitance	$V_{DS}=30V, V_{GS}=0V, F=1MHz$	---	520	1040	
$C_{rss}$	Reverse Transfer Capacitance		---	30	60	
$R_g$	Gate resistance	$V_{GS}=0V, V_{DS}=0V, F=1MHz$	---	1.2	---	$\Omega$

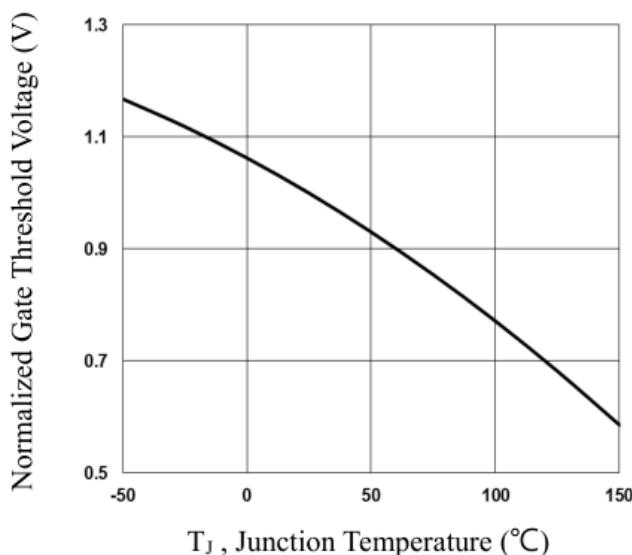
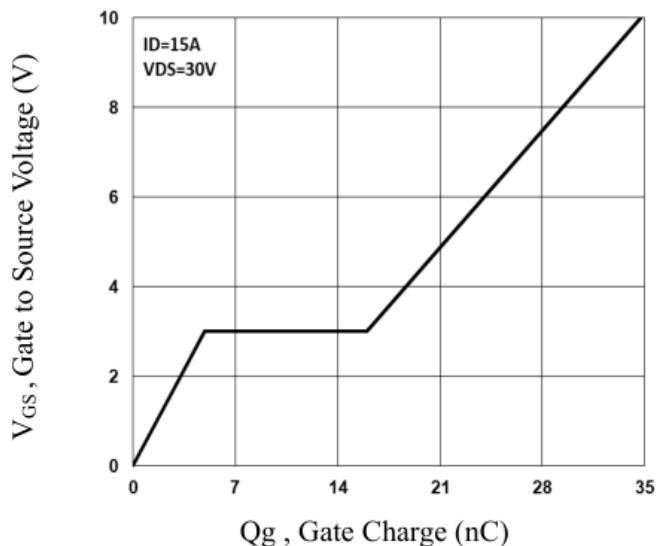
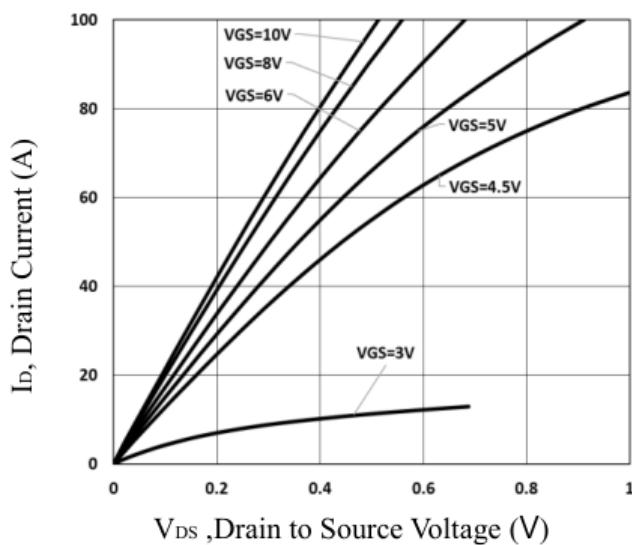
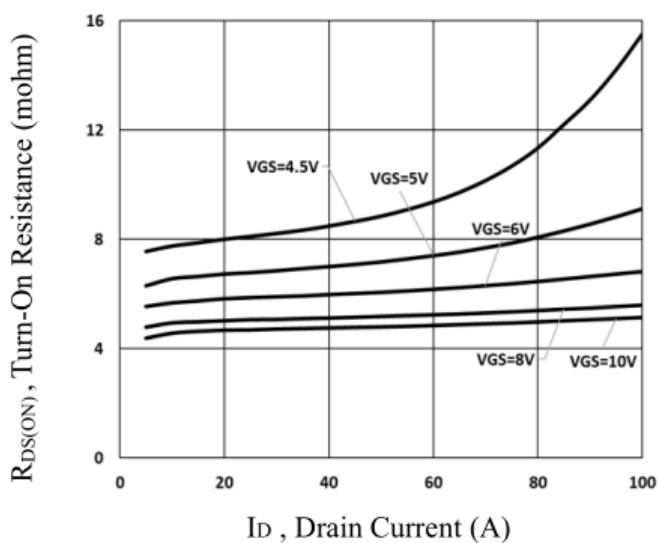
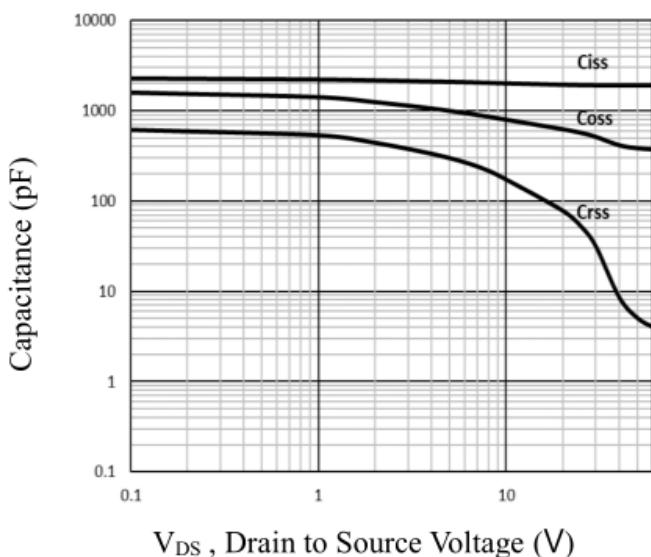
**Drain-Source Diode Characteristics and Maximum Ratings**

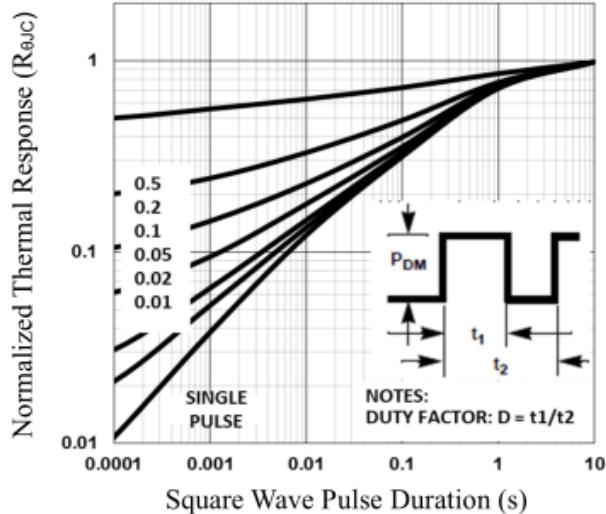
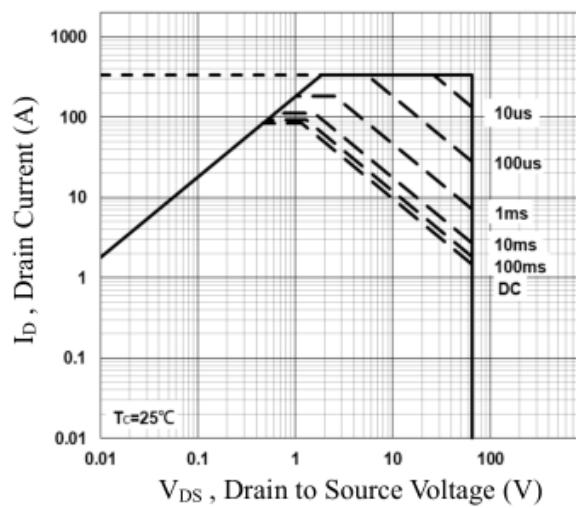
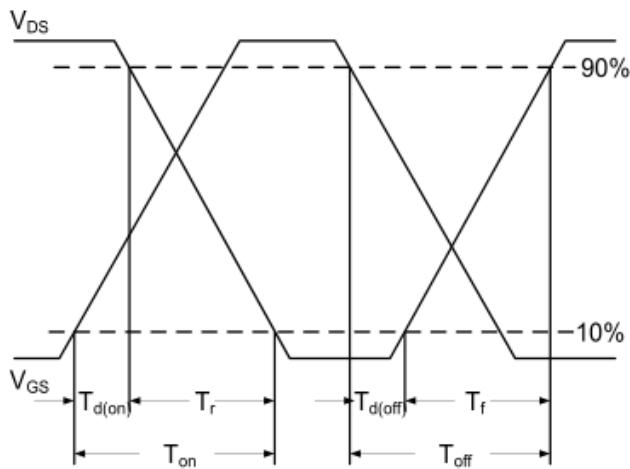
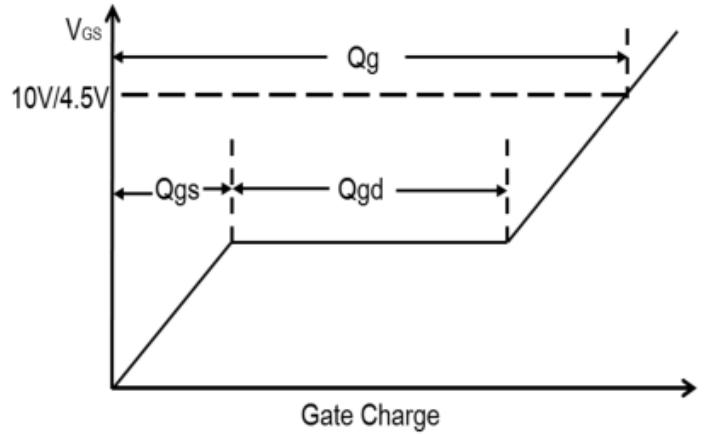
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_S$	Continuous Source Current	$V_G=V_D=0V, \text{Force Current}$	---	---	83	A
$I_{SM}$	Pulsed Source Current		---	---	166	A
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0V, I_S=1A, T_J=25^\circ C$	---	---	1	V
$T_{rr}$	Reverse Recovery Time	$V_{GS}=10V, I_S=10A, di/dt=100A/\mu s, T_J=25^\circ C$	---	48.4	---	ns
$Q_{rr}$	Reverse Recovery Charge		---	54.2	---	nC

Note :

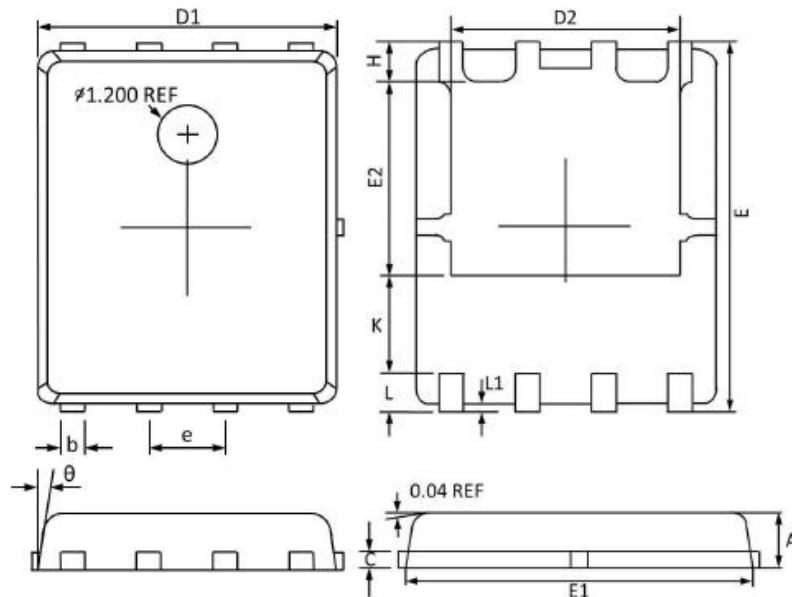
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2.  $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=53A., R_G=25\Omega, \text{Starting } T_J=25^\circ C.$
3. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .
4. Essentially independent of operating temperature.


**Fig.1 Continuous Drain Current vs.  $T_C$** 

**Fig.2 Normalized RDS(on) vs.  $T_J$**


**Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>**

**Fig.4 Gate Charge Characteristics**

**Fig.5 Typical Output Characteristics**

**Fig.6 Turn-On Resistance vs. I<sub>D</sub>**

**Fig.7 Capacitance Characteristics**


**Fig.8 Normalized Transient Impedance**

**Fig.9 Maximum Safe Operation Area**

**Fig.10 Switching Time Waveform**

**Fig.11 Gate Charge Waveform**

## DFN5\*6 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	1.100	0.800	0.043	0.031
b	0.510	0.330	0.020	0.013
C	0.300	0.200	0.012	0.008
D1	5.100	4.800	0.201	0.189
D2	4.100	3.610	0.161	0.142
E	6.200	5.900	0.244	0.232
E1	5.900	5.700	0.232	0.224
E2	3.780	3.350	0.149	0.132
e	1.27BSC		0.05BSC	
H	0.700	0.410	0.028	0.016
K	1.500	1.100	0.059	0.043
L	0.710	0.510	0.028	0.020
L1	0.200	0.060	0.008	0.002
θ	12°	0°	12°	0°